ESRF	Experiment title: Relaxational dynamics of supercritical water	Experiment number: HS-2606
Beamline: ID28	Date of experiment : 17.9. – 26.9.2004	Date of report: 28 September 2005
Shifts: 24	Local contact(s): M. Krisch	Received at ESRF:

Names and affiliations of applicants (* indicates experimentalists):

• F. Bencivenga^{1*}, M. Krisch^{1*}, A. Cunsolo^{2*}

¹ESRF; ²ILL

Report:

The high-frequency dynamics of liquid and supercritical water has been studied by inelastic x-ray scattering (IXS). The experiment was performed at an incident photon energy of 21.747 KeV, using the silicon (11,11,11) set-up, providing an overall energy resolution of 1.5 meV (FWHM). The sample has been embedded in a specially designed large volume (\sim 0.7 cm 3) high-pressure, high-temperature cell made out of Inconel. The experiment was performed in isobaric (400 bar) conditions varying the temperature of the sample from 293 K up to 706 K, above the critical point of water (T_c =647 K and P_c =221 bar). The investigated temperatures were: 293, 337, 423, 447, 549, 660 and 706 K. For each thermodynamic point, we acquired one diffraction pattern and 10 IXS spectra in a momentum transfer range between 2 and 15.5 nm $^{-1}$. 2 or 3 spectra with an integration time of 4h each were accumulated in order to have sufficient statistics. The contribution of the empty cell was measured as well and yielded a negligible contribution to the signal.

In figure 1 we report some selected diffraction patterns, S(Q). The intensity of the first sharp diffraction peak decreases while approaching the critical temperature (647 K) while at low-Q a large increase of the scattering due to the insurgence of critical fluctuations is observed [1]. Figure 2 shows representative IXS spectra, together with their best fit result. This fit was obtained using a model based on a viscoelastic function taking into account one structural relaxation process, the thermal diffusion and a "microscopic" term (for further details see [2-4]). This model function has been convoluted with the experimentally determined resolution function.

Figures 3 and 4 report the main results concerning the structural relaxation: its characteristic timescale τ and strength, Δ . While τ shows an almost linear Q-dependence, Δ is constant throughout the explored Q range. Both quantities decrease with increasing temperature. From the viscoelastic analysis, we can also derive the value of the isothermal and infinite frequency sound dispersion, $\Omega_0(Q)$ and $\Omega_{inf}(Q)$. Alternatively, $\Omega_0(Q)$ can also be derived from the S(Q) measurements, and the values derived by the two approaches are in excellent agreement. Finally, from the maximum of the longitudinal current spectrum, $\omega^2 S(Q,\omega)$, we can derive the apparent sound dispersion, $\Omega_L(Q)$, that represents the characteristic frequency of sound propagation [2-4].

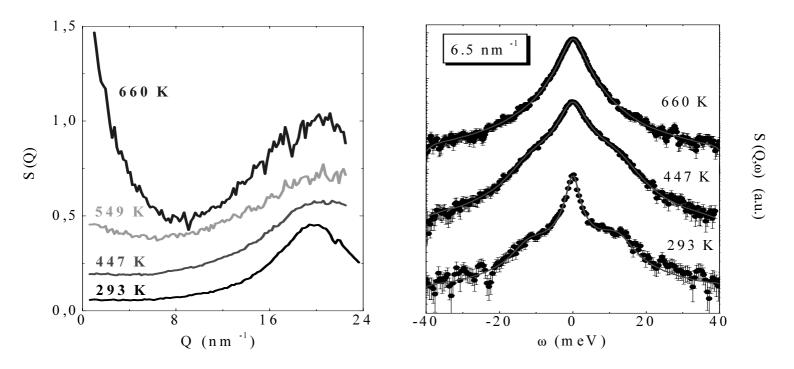


Fig. 1 (left): Diffraction patterns of liquid water at P = 400bar and the indicated temperatures. See text for more details.

Fig. 2 (right): IXS spectra of liquid water at Q=6.5 nm⁻¹ at 400bar and the indicated temperatures. The experimental data (circles) and their error bars are shown together with the best fit (red full line). See text for further details.

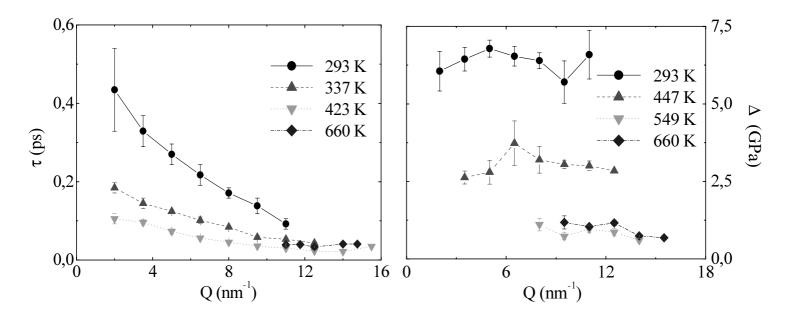


Fig. 3 (left): Characteristic time τ of the structural relaxation.

Fig. 4 (right): Strength, Δ , of the structural relaxation.

References

- [1] M. C. Bellissent-Funel et al.; J. Chem. Phys. 107, 2942 (1997)
- [2] U. Balucani et al.; Phys. Rev. E 47, 1677 (1993)
- [3] G. Monaco et al.; Phys. Rev. E 60, 5505 (1999)
- [4] T. Scopigno et al.; Rev. Mod. Phys. 77, 881 (2005)